

Notice of References Cited	Application/Control No. 09/785,402		Applicant(s)/Pat nt Under Reexamination TAKACHIO ET AL.	
	Examin r David C. Payne		Art Unit 2633	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,147,786	11-2000	Pan, Jin-Yi	398/1
	B	US-H0,002,075	08-2003	Gnauck et al.	398/58
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
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	M	US-			

FOREIGN PATENT DOCUMENTS

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	N					
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NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
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